

Vishay Siliconix

# N-Channel 75 V (D-S) MOSFET

PRODUCT SUMMARY						
V <sub>DS</sub> (V)	$R_{DS(on)}(\Omega)$	I <sub>D</sub> (A)	Q <sub>g</sub> (Typ.)			
75	0.007 at V <sub>GS</sub> = 10 V	110 <sup>d</sup>	69			

#### **FEATURES**

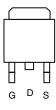
**APPLICATIONS** 

- TrenchFET® Power MOSFETS
- 100 %  $\rm R_{\rm g}$  and UIS Tested

Material categorization: For definitions of compliance please see www.vishav.com/doc?99912

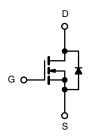






Top View

· Synchronous Rectification



N-Channel MOSFET

Ordering Information: SUM110N08-07P-E3 (Lead (Pb)-free)

Parameter	Symbol	Limit	Unit		
Drain-Source Voltage	V <sub>DS</sub>	75	V		
Gate-Source Voltage	V <sub>GS</sub>	± 20	7 v		
Continuous Drain Current (T <sub>.I</sub> = 150 °C)	T <sub>C</sub> = 25 °C	I-	110 <sup>d</sup>	A	
Continuous Diain Current (1) = 130 °C)	T <sub>C</sub> = 70 °C	I <sub>D</sub>	103		
Pulsed Drain Current	I <sub>DM</sub>	180	Α .		
Avalanche Current	I <sub>AS</sub>	50			
Single Avalanche Energy <sup>a</sup>	L = 0.1 mH	E <sub>AS</sub>	125	mJ	
Mariana Barra Birainatina	T <sub>C</sub> = 25 °C	В	208.3 <sup>b</sup>	147	
Maximum Power Dissipation <sup>a</sup>	T <sub>A</sub> = 25 °C <sup>c</sup>	P <sub>D</sub>	3.75	W	
Operating Junction and Storage Temperature Ra	T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	°C		

THERMAL RESISTANCE RATINGS						
Parameter	Symbol	Limit	Unit			
Junction-to-Ambient (PCB Mount) <sup>c</sup>	R <sub>thJA</sub>	40	°C/W			
Junction-to-Case (Drain)	R <sub>thJC</sub>	0.6	C/VV			

## Notes:

- a. Duty cycle  $\leq$  1 %.
- b. See SOA curve for voltage derating.
- c. When mounted on 1" square PCB (FR-4 material).
- d. Package limited.

## SUM110N08-07P

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<b>SPECIFICATIONS</b> (T <sub>J</sub> = 25 °C, unless otherwise noted)								
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit		
Static								
Drain-Source Breakdown Voltage	$V_{DS}$	$V_{DS} = 0 \text{ V}, I_{D} = 250 \mu\text{A}$	75			V		
Gate Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	2.5		4.5	V		
Gate-Body Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 250	nA		
		V <sub>DS</sub> = 75 V, V <sub>GS</sub> = 0 V			1			
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{DS} = 75 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 125 ^{\circ}\text{C}$			50	μΑ		
		V <sub>DS</sub> = 75 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 150 °C			250			
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 10 \text{ V}, V_{GS} = 10 \text{ V}$	70			Α		
D : 0	D	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 20 A		0.0057	0.0070	0		
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 20 A, T <sub>J</sub> = 125 °C		0.0092	0.0112	Ω		
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = 15 V, I <sub>D</sub> = 20 A		43		S		
Dynamic <sup>b</sup>								
Input Capacitance	C <sub>iss</sub>			4250		pF		
Output Capacitance	C <sub>oss</sub>	$V_{GS} = 0 \text{ V}, V_{DS} = 30 \text{ V}, f = 1 \text{ MHz}$		580				
Reverse Transfer Capacitance	C <sub>rss</sub>			230				
Total Gate Charge <sup>c</sup>	$Q_g$			69	105	nC		
Gate-Source Charge <sup>c</sup>	$Q_{gs}$	$V_{DS} = 30 \text{ V}, V_{GS} = 10 \text{ V}, I_{D} = 50 \text{ A}$		23				
Gate-Drain Charge <sup>c</sup>	$Q_{gd}$			21				
Gate Resistance	$R_{g}$	f = 1 MHz		1.2	2.4	Ω		
Turn-On Delay Time <sup>c</sup>	t <sub>d(on)</sub>			17	30			
Rise Time <sup>c</sup>	t <sub>r</sub>	$V_{DD} = 30 \text{ V}, R_{L} = 0.6 \Omega$		5	10	1		
Turn-Off Delay Time <sup>c</sup>	t <sub>d(off)</sub>	$I_D \cong 50 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$		22	40	ns		
Fall Time <sup>c</sup>	t <sub>f</sub>			6	15			
Source-Drain Diode Ratings and Characteristics T <sub>C</sub> = 25 °C <sup>b</sup>								
Continuous Current	Is				110			
Pulsed Current	I <sub>SM</sub>				180	Α		
Forward Voltage <sup>a</sup>	$V_{SD}$	$I_F = 20 \text{ A}, V_{GS} = 0 \text{ V}$		0.83	1.5	V		
Reverse Recovery Time	t <sub>rr</sub>			65	100	ns		
Peak Reverse Recovery Current	I <sub>RM(REC)</sub>	I <sub>F</sub> = 75 A, dI/dt = 100 A/μs		2.5	5	Α		
Reverse Recovery Charge				85	150	nC		

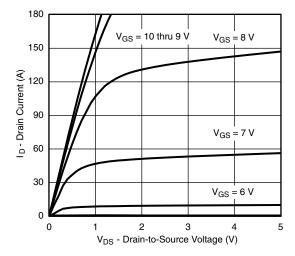
#### Notes:

- a. Pulse test; pulse width  $\leq 300~\mu s,$  duty cycle  $\leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.
- c. Independent of operating temperature.

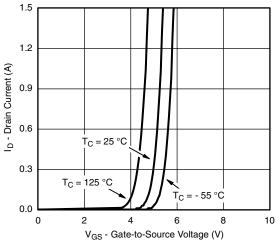
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



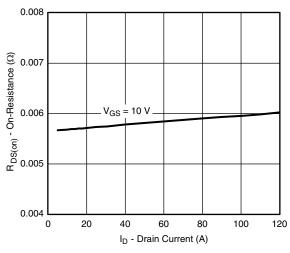
## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



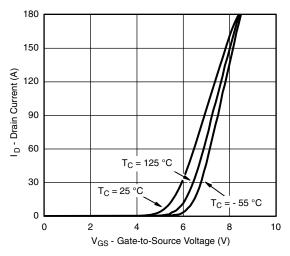
### **Output Characteristics**



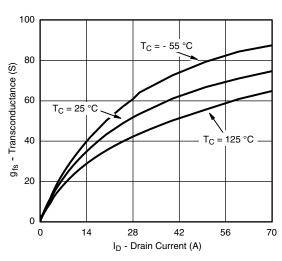
### **Transfer Characteristics**



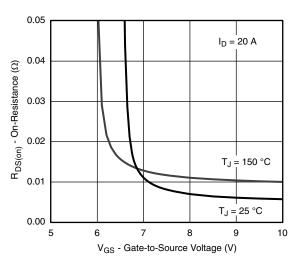
On-Resistance vs. Drain Current



### **Transfer Characteristics**



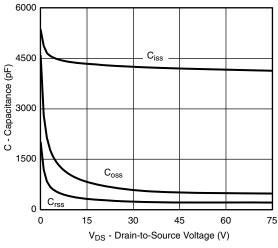
Transconductance



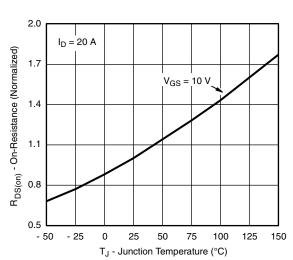
On-Resistance vs. Gate-to-Source Voltage

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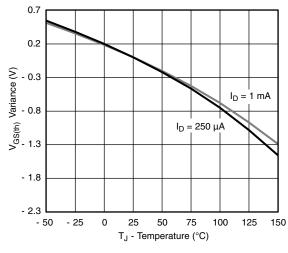
## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



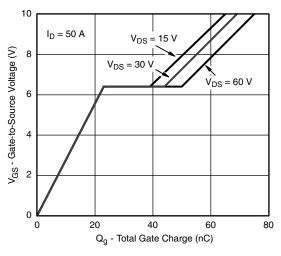




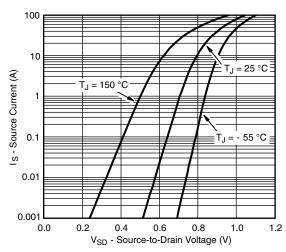
On-Resistance vs. Junction Temperature



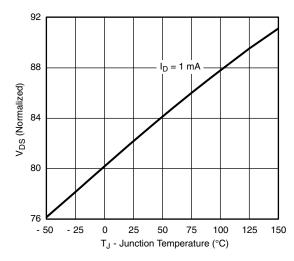
Threshold Voltage



**Gate Charge** 



Source-Drain Diode Forward Voltage

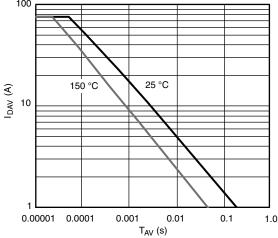


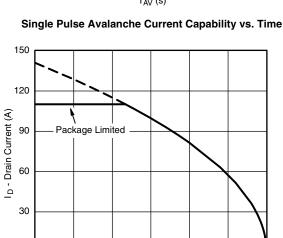
Drain Source Breakdown vs. Junction Temperature



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## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)





75

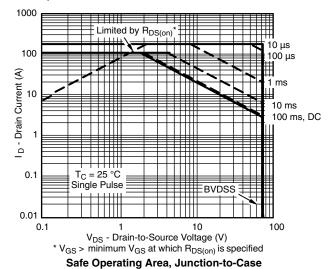
T<sub>C</sub> - Case Temperature (°C)

Current Derating\*, Junction-to-Case

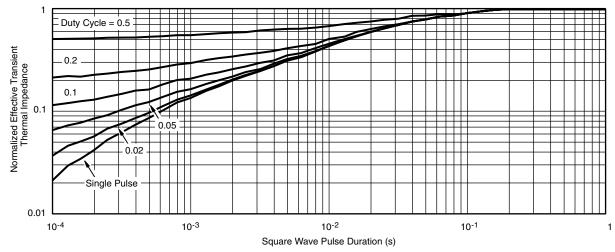
100

125

150



 $<sup>^{\</sup>star}$  The power dissipation  $P_{D}$  is based on  $T_{J(max)}$  = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



Normalized Thermal Transient Impedance, Junction-to-Case

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see /www.vishay.com/ppg?68637.

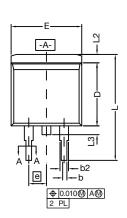
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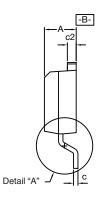
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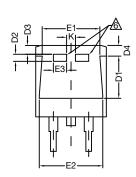
25



# TO-263 (D<sup>2</sup>PAK): 3-LEAD

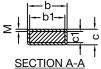








DETAIL A (ROTATED 90°)



_	,	—b <del>-</del> -b	 			1
2	T			C	_ (	<u>-</u>
	SE	^TIC	M	ا م		1

- 1. Plane B includes maximum features of heat sink tab and plastic.
- 2. No more than 25 % of L1 can fall above seating plane by max. 8 mils.
- 3. Pin-to-pin coplanarity max. 4 mils.
- 4. \*: Thin lead is for SUB, SYB. Thick lead is for SUM, SYM, SQM.
- 5. Use inches as the primary measurement.

6 This feature is for thick lead.

	INCHES		HES	MILLIMETERS			
	DIM.	MIN.	MAX. MIN		MAX.		
Α		0.160	0.190	4.064	4.826		
	b	0.020	0 0.039 0.5		0.990		
	b1	0.020	0.035	0.508	0.889		
	b2	0.045	0.055	1.143	1.397		
c*	Thin lead	0.013	0.018	0.330	0.457		
	Thick lead	0.023	0.028	0.584	0.711		
c1	Thin lead	0.013	0.017	0.330	0.431		
CI	Thick lead	0.023	0.027	0.584	0.685		
	c2	0.045	0.055	1.143	1.397		
	D	0.340	0.380	8.636	9.652		
	D1	0.220	0.240	5.588	6.096		
	D2	0.038	0.042	0.965	1.067		
	D3	0.045	0.055	1.143	1.397		
	D4	0.044	0.052	1.118	1.321		
	Е	0.380	0.410	9.652	10.414		
	E1	0.245	-	6.223	-		
	E2	0.355	0.375	9.017	9.525		
	E3	0.072	0.078	1.829	1.981		
	е	0.100	BSC	2.54 BSC			
	K	0.045	0.055	1.143	1.397		
	L	0.575	0.625	14.605	15.875		
L1		0.090	0.110	2.286	2.794		
	L2	0.040	0.055	1.016	1.397		
	L3	0.050	0.070	1.270	1.778		
	L4	0.010	BSC	0.254 BSC			
	М	-	0.002	-	0.050		
ECN: T13-0707-Rev. K, 30-Sep-13							

DWG: 5843





## RECOMMENDED MINIMUM PADS FOR D<sup>2</sup>PAK: 3-Lead



Recommended Minimum Pads Dimensions in Inches/(mm)

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Please note that some Vishay documentation may still make reference to RoHS Directive 2002/95/EC. We confirm that all the products identified as being compliant to Directive 2002/95/EC conform to Directive 2011/65/EU.

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Revision: 02-Oct-12 Document Number: 91000